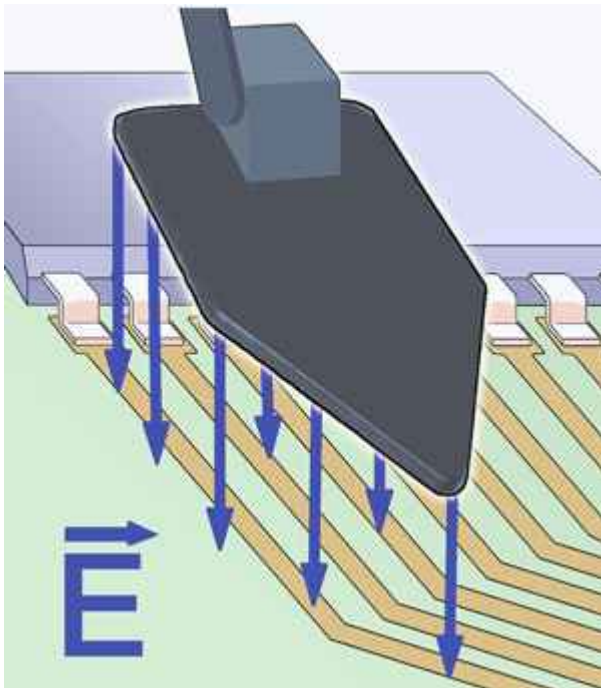


### Short description

The surface of the E field source head allows the extensive coupling into housing surfaces and interior areas, connection technology and assemblies with conducting path structures and ICs ( e.g. bus systems, LCD displays). Furthermore its tip can be used for the localization of small E- field sensitive weak spots (conducting paths, quartz crystal, pull-up resistance, ICs).

The resolution of ES 02 is higher than the resolution of ES 01 field source.

### Measuring principles



# ES 02

E-Field Source

## Application ES 02

